

264240US2PCT

# JC03 Rec'd PCT/PTO 18 MAR 2005

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

David W. SHEEL, et al.

SERIAL NO:

): 10/522,185

GAU:

FILED:

January 24, 2005

**EXAMINER:** 

EOR:

TITANIA COATINGS BY CVD AT ATMOSPHERIC PRESSURE

## **INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97**

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

RECEIVED OIPE/IAP

SIR:

Applicant(s) wish to disclose the following information.

SEP 2 7 2005

#### REFERENCES

The applicant(s) wish to make of record the references cited in the International Search Report and listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

#### RELATED CASES

Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

#### **CERTIFICATION**

☐ Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

□ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

### **DEPOSIT ACCOUNT**

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number <u>15-0030</u>. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO.		SERIAL NO.						
		264240US2PCT		10/522,185						
			APPLICANT							
LIST OF REFERENCES CITED BY APPLICANT		David W. SHEEL, et al.								
		FILING DATE		GROUP						
		January 24, 2005								
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS		SUB CLASS				
	AA	2003/0072891	04/17/03	MURAKAMI, Takashi et al.						
	AB	5 993 916	11/30/99	ZHAO, Jun et al.						
	AC	2001/0025205	09/27/01	CHERN, Chyi et al.						
	AD	6 329 237	12/11/01	KIM, Kyong Min et al.						
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	AF	5 295 220	03/15/94	HEMING, Martin et al.						
	AG									
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<u></u>	Al									
	AJ									
	AK						<u>.</u>			
	AL									
	AM									
	AN							-		
	FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO				
	AO	2000 313962	11/14/00	JP (with English abstract)				NO		
	AP	8 253322	10/01/96	JP (with English abstract)				NO		
	AQ	02 48428	06/20/02	WO (with English abstract)				NO		
	AR									
	AS									
	AT									
	AU									
	AV									
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)										
	AW									
	AX									
	AY									
	AZ			Additional References sheet(s) attached						
Examiner					Date Considered					
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										